

NCE N-Channel Enhancement Mode Power MOSFET

Description

The NCE0125Al uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

● $V_{DS} = 100V, I_D = 25A$ $R_{DS(ON)} < 36mΩ @ V_{GS} = 10V$ (Typ:31 mΩ)

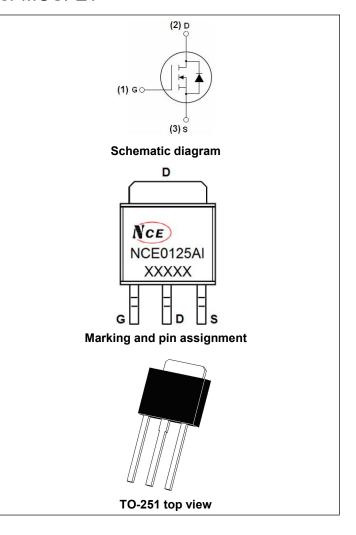
- Special process technology for high ESD capability
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation

Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

100% UIS TESTED!

100% AVds TESTED!



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
NCE0125AI	NCE0125AI	TO-251-3L	-	-	-

Absolute Maximum Ratings (T_C=25℃unless otherwise noted)

Symbol	Parameter	Limit	Unit
V _{DS}	Drain-Source Voltage	100	V
V _G s	Gate-Source Voltage	±20	V
I _D	Drain Current-Continuous	25	Α
I _D (100℃)	Drain Current-Continuous(TC=100℃)	17.6	Α
I _{DM}	Pulsed Drain Current	70	Α
P _D	Maximum Power Dissipation	70	W
	Derating factor	0.5	W/℃
E _{AS}	Single pulse avalanche energy (Note 5)	110	mJ
T _J ,T _{STG}	Operating Junction and Storage Temperature Range	-55 To 175	°C

NCE0125AI

Thermal Characteristic

R _{BJC} Thermal Resistance, Junction-to-Case (Note	2) 2	°C/W
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Electrical Characteristics (T_C=25°C unless otherwise noted)

	Symbol	Parameter	Condition	Min	Тур	Max	Unit
Off Characteri	stics	•					
BV _{DSS}	Drain-Source Breakdo	own Voltage	V _{GS} =0V I _D =250µA	100	110	-	V
I _{DSS}	Zero Gate Voltage Di	rain Current	V _{DS} =100V,V _{GS} =0V	-	-	1	μA
I _{GSS}	Gate-Body Leakag	e Current	V_{GS} =±20 V , V_{DS} =0 V	-	-	±100	nA
On Characteri	stics (Note 3)				,		•
V _{GS(th)}	Gate Threshold \	Voltage	$V_{DS}=V_{GS},I_{D}=250\mu A$	0.8	1.2	1.6	V
R _{DS(ON)}	Drain-Source On-State	e Resistance	V _{GS} =10V, I _D =15A	-	31	36	mΩ
g FS	Forward Transcon	ductance	V _{DS} =5V,I _D =15A	-	12	-	S
Dynamic Char	racteristics (Note4)	'		•	'		,
C _{lss}	Input Capacita	ance	., 50,(), 0),	-	3000	-	PF
Coss	Output Capaci	tance	$V_{DS}=50V, V_{GS}=0V,$	-	92	-	PF
Crss	Reverse Transfer Ca	apacitance	F=1.0MHz - 18.3		-	PF	
Switching Cha	aracteristics (Note 4)			'			
t _{d(on)}	Turn-on Delay	Time		-	9	-	nS
t _r	Turn-on Rise	Time	V_{DD} =50 V , R_L =5 Ω	-	9	-	nS
$t_{d(off)}$	Turn-Off Delay	Time	V_{GS} =10 V , R_{GEN} =3 Ω	-	31	-	nS
t _f	Turn-Off Fall	Гіте		-	9	-	nS
Qg	Total Gate Ch	arge)/ F0)/ OFA	-	70.4	-	nC
Q _{gs}	Gate-Source C	harge	$V_{DS}=50V,I_{D}=25A,$	-	9.0	-	nC
Q _{gd}	Gate-Drain Ch	arge	V _{GS} =10V	-	15.3	-	nC
Drain-Source	Diode Characteristics			•			,
V _{SD}	Diode Forward Volt	tage (Note 3)	V _{GS} =0V,I _S =25A	-	-	1.2	V
Is	Diode Forward Cur	rent (Note 2)	-	-	-	25	Α
t _{rr}	Reverse Recover	y Time	TJ = 25°C, IF = 25A	-	34	-	nS
Qrr	Reverse Recovery	Charge	$di/dt = 100A/\mu s^{(Note3)}$	-	56	-	nC

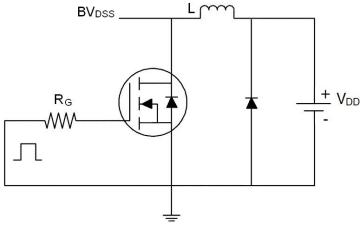
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS Condition : Tj=25 $^{\circ}\text{C}$,VDD=50V,VG=10V,L=0.5mH,Rg=25 Ω

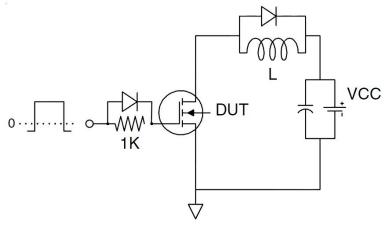


Test Circuit

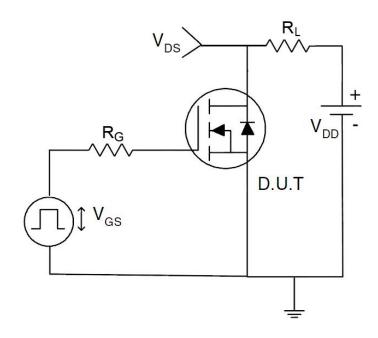
1) E_{AS} Test Circuit



2) Gate Charge Test Circuit



3) Switch Time Test Circuit





Typical Electrical and Thermal Characteristics (Curves)

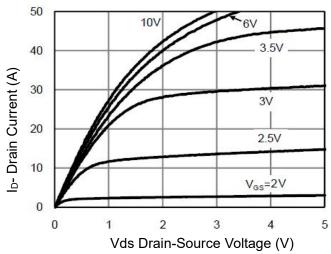


Figure 1 Output Characteristics

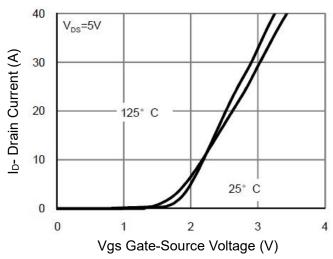


Figure 2 Transfer Characteristics

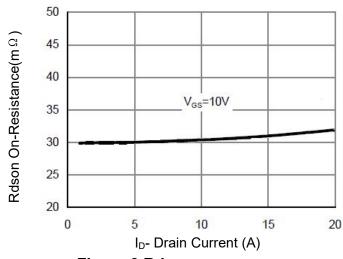


Figure 3 Rdson- Drain Current

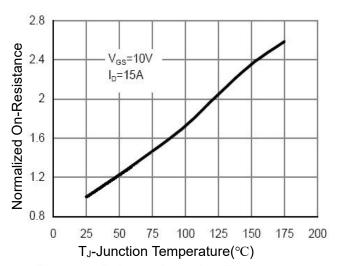


Figure 4 Rdson-JunctionTemperature

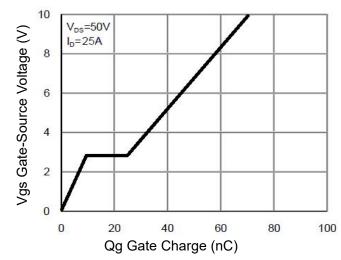


Figure 5 Gate Charge

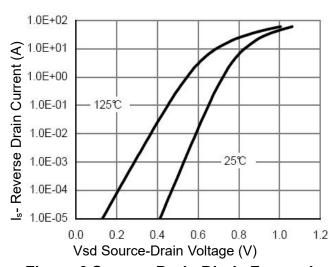


Figure 6 Source- Drain Diode Forward



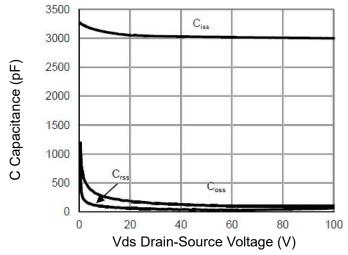


Figure 7 Capacitance vs Vds

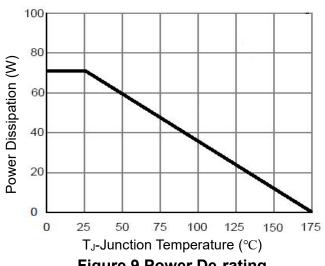


Figure 9 Power De-rating

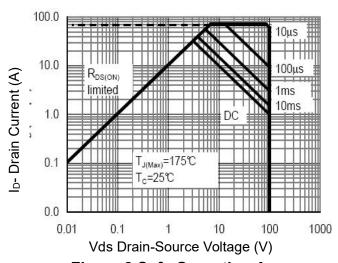


Figure 8 Safe Operation Area

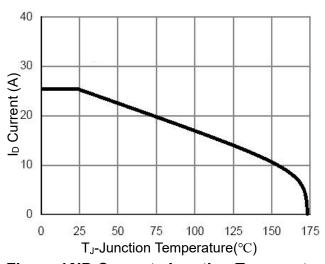


Figure 10ID Current- Junction Temperature

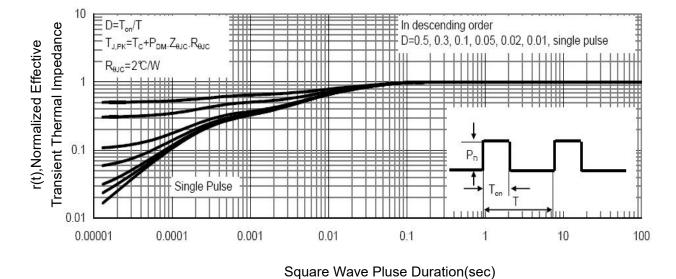
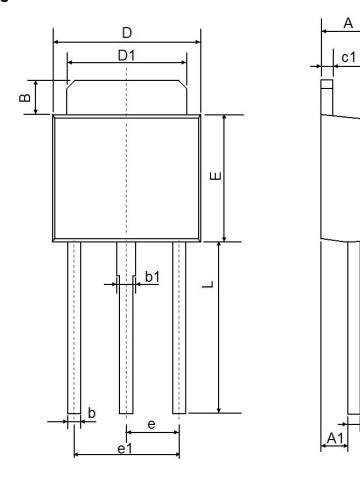


Figure 11 Normalized Maximum Transient Thermal Impedance



TO-251 Package Information



Comple of	Dimensions	n Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	2.200	2.400	0.087	0.094	
A1	1.050	1.350	0.042	0.054	
В	1.350	1.650	0.053	0.065	
b	0.500	0.700	0.020	0.028	
b1	0.700	0.900	0.028	0.035	
С	0.430	0.580	0.017	0.023	
c1	0.430	0.580	0.017	0.023	
D	6.350	6.650	0.250	0.262	
D1	5.200	5.400	0.205	0.213	
Е	5.400	5.700	0.213	0.224	
е	2.300 TYP		0.091	TYP	
e1	4.500	4.700	0.177	0.185	
L	7.500	7.900	0.295	0.311	



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